## **Notice of References Cited**

Application/Control No.

09/469,505

Examiner

Christian La Forgia

Applicant(s)/Patent Under
Reexamination
STONE ET AL.

Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,014,628	01-2000	Kovarik, Jr., Vincent J.	705/1
	В	US-6,301,668	10-2001	Gleichauf et al.	713/201
	С	US-6,327,242	12-2001	Amicangioli et al.	370/216
	D	US-6,535,227	03-2003	Fox et al.	345/736
	Ε	US-6,499,107	12-2002	Gleichauf et al.	713/201
	F	US-6,282,546	08-2001	Gleichauf et al.	707/102
	G	US-6,182,226	01-2001	Reid et al.	713/201
	Н	US-6,185,689	02-2001	Todd et al.	713/201
	1	US-6,157,649	12-2000	Peirce et al.	370/401
	J	US-6,484,203	11-2002	Porras et al.	709/224
	К	US-6,321,338	11-2001	Porras et al.	713/201
	L	US-			te.
	М	US-			* * * * * * * * * * * * * * * * * * * *

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S				`	
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.